


<b>Search Notes</b>  	<b>Application/Control No.</b>  10820469	<b>Applicant(s)/Patent Under Reexamination</b>  MAO, XIADONG
	<b>Examiner</b>  DEVONA E FAULK	<b>Art Unit</b>  2614

SEARCHED			
Class	Subclass	Date	Examiner
463	35	11/18/08	DEF
381	92,71.11	11/18/08	DEF
700	94	11/18/08	DEF
345	156-157,161,163	11/18/08	DEF
273	148B,148R	11/18/08	DEF
700	94	5/5/09	DEF
381	92,71.11,17	5/5/09	DEF
463	35,37	5/5/09	DEF
345	156-157,161,163	5/5/09	DEF
273	148B,148R	5/5/09	DEF
381	61-63,92,71.11	11/9,10/09	DEF
700	94	11/9/09	DEF
345	156-157,161,163	11/9/09	DEF
463	35,37	11/9/09	DEF
273	148B,148R	11/10/09	DEF
463	35,37	6/6/10	DEF
381	92,61-63,71.11	6/6/10	DEF
273	148B, 148R	6/6/10	DEF
381	61-63,92,71.11	9/30/10	DEF
463	35,37	9/30/10	DEF
273	148B,148R	9/30/10	DEF

SEARCH NOTES		
Search Notes	Date	Examiner
assignee/inventor search	10/10/08	DEF
word search	10/30/08, 11/18/08	DEF
consulted with Mark Sager of class 463, suggested 463/35; 273/148B,148R; 345/156-157,161,163	11/18/08	DEF
word search; combined class word search	11/19/08	DEF
additional search	5/5,7/09	DEF
additional search	11/9,10/09	DEF
additional search	6/6/10	DEF
additional search	9/30/10	DEF

	/DEVONA E FAULK/ Primary Examiner.Art Unit 2614
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<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

	/DEVONA E FAULK/ Primary Examiner.Art Unit 2614
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